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Milpitas, CA 95035



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To:	Remmon R. Forde	From:	Peter P. Scott
Fax:	703.872.9306	Pages:	4
Phone:	571.272.1916	Date:	9 March 2005

Appl. No.	:	10/730,554	Confirmation No.	1517
Applicant	:	Sean Christopher Erickson		
Filed	:	8 December 2003		
TC/A.U.	:	2826		
Examiner	:	Remmon R. Forde		
Docket No.	:	03-1141		
Customer No.	:	24319		

RE: Response to Restriction Requirement

Attached to this cover sheet is Applicant's response to the Examiner's restriction requirement.

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Sean Christopher Erickson

Group Art Unit: 2826

Serial No.: 10/730,554

Filed: 8 December 2003

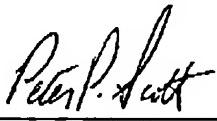
Attorney Docket No: 03-1141

For: High Performance Diode Implanted  
Voltage Controlled P-Type  
Diffusion Resistor

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Peter P. Scott

**RESPONSE TO RESTRICTION REQUIREMENT**

Mail Stop Amendment  
Commissioner for Patents  
PO Box 1450  
Alexandria, VA 22313-1450

Attention: Remmon R. Forde  
Examiner  
571.272.1916

Dear Sir:

The Applicant respectfully responds to the Office Action mailed 25 February 2005 as follows:

RESPONSE

The Examiner required restriction to one of the following inventions under 35 U.S.C. 121:

- I. Claims 1-9 drawn to a semiconductor device; or
- II. Claims 10-19 drawn to a method of making a semiconductor device.

The Applicant respectfully traverses the requirement for restriction made by the Examiner under 35 U.S.C. 121 on the grounds that examination of all claims would not impose an undue burden on the examiner.

Notwithstanding the foregoing, the Applicant provisionally elects the claims of Group I, claims 1-9, drawn to a semiconductor device.

If it is felt for any reason that direct communication with the Applicant's attorney would serve to advance prosecution of this case to finality, the Examiner is invited to call the undersigned Peter P. Scott at the telephone number below.

**AUTHORIZATION TO PAY AND PETITION  
FOR THE ACCEPTANCE OF ANY NECESSARY FEES**

If any charges or fees must be paid in connection with this communication (including but not limited to the payment of an extension fee or issue fees), or if any overpayment is to be refunded in connection with the present application, any such charges or fee, or any such overpayment may be respectively paid out of, or into, the Deposit Account No. 12-2252 of LSI Logic Corporation. If any such payment also requires a Petition or Extension Request, please construe this authorization as the required Petition or Request.

Respectfully submitted,

**Sean Christopher Erickson**

By:



Peter P. Scott  
Attorney for Applicant  
Reg. No. 33,279

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Date: 3/9/05

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